

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/800,415	ORR, DAVID	
Examiner Colleen Quinn CMQ James C. Dooley 08/14/06		Art Unit 3634	Page 1 of 3	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,735,020 A	05-1973	Licata, Joseph	174/66
*	B	US-4,464,084 A	08-1984	Wozniak, Jan C.	405/288
*	C	US-4,712,694 A	12-1987	Breslow, David	211/184
*	D	US-4,914,874 A	04-1990	Graham, Jr., Andrew S.	52/79.1
*	E	US-5,474,347 A	12-1995	Vigneault et al.	292/340
*	F	US-5,711,587 A	01-1998	Takahashi et al.	312/265.6
*	G	US-5,783,777 A	07-1998	Kruse et al.	174/66
*	H	US-6,102,501 A	08-2000	Chen et al.	312/223.2
*	I	US-6,597,576 B1	07-2003	Smith et al.	361/724
*	J	US-6,711,008 B2	03-2004	Teng et al.	361/683
*	K	US-6,751,100 B2	06-2004	Chen, Yun-Lung	361/725
*	L	US-6,816,370 B2	11-2004	Searby et al.	361/685
*	M	US-6,874,646 B2	04-2005	Jay, Richard	211/59.2

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,889,016 A	06-1959	JACK WARREN	52/98
*	B	US-4,283,034 A	08-1981	Sheehan, Maurice J.	248/263
*	C	US-5,011,418 A	04-1991	Perzentka, Jr., Thomas R.	439/135
*	D	US-5,191,544 A	03-1993	Benck et al.	361/688
*	E	US-5,199,776 A	04-1993	Lin, Chung H.	312/293.3
*	F	US-5,242,223 A	09-1993	Koves, Thomas	312/348.3
*	G	US-5,665,442 A	09-1997	Andersen et al.	428/36.4
*	H	US-5,730,515 A	03-1998	Ho, Hsin Chien	312/350
*	I	US-6,362,955 B1	03-2002	Felcman et al.	361/683
*	J	US-6,390,320 B2	05-2002	Hurst et al.	220/241
*	K	US-6,471,177 B1	10-2002	Emrick et al.	248/544
*	L	US-6,590,848 B1	07-2003	Chen, Chia Hua	720/654
*	M	US-6,601,356 B2	08-2003	Snyder, Darryl L.	52/302.1

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,312,005 A	05-1994	Odell, Gordon T.	211/189
*	B	US-5,542,757 A	08-1996	Chang, Chia-Chi	312/223.2
*	C	US-5,615,850 A	04-1997	Cloninger, Leonard W.	248/68.1
*	D	US-5,624,042 A	04-1997	Flum et al.	211/59.2
*	E	US-5,884,782 A	03-1999	Dembicks, Andrew E.	211/70.6
*	F	US-6,278,606 B1	08-2001	Schmitt et al.	361/683
*	G	US-6,942,000 B2	09-2005	Hoerner et al.	160/229.1
*	H	US-6,631,813	10-2003	Walter et al.	211/94.01
*	I	US-6,257,425	07-2001	Liu, Chao-Min	211/90.01
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
	X	

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